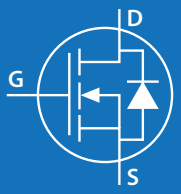
EPC2071 – Enhancement Mode Power Transistor

V_{DS}, 100 V
$R_{DS(on)}$, 1.7 mΩ typical, 2.2 mΩ max
I_D, 64 A



EFFICIENT POWER CONVERSION

RoHS Halogen-Free

Revised November 26, 2024

Gallium Nitride's exceptionally high electron mobility and low temperature coefficient allows very low $R_{DS(on)}$, while its lateral device structure and majority carrier diode provide exceptionally low Q_G and zero Q_{RR}. The end result is a device that can handle tasks where very high switching frequency, and low on-time are beneficial as well as those where on-state losses dominate.

Application Notes:

- Easy-to-use and reliable gate
- Gate Drive ON = 5–5.25 V typical, OFF = 0 V (negative voltage not needed)
- Recommended dead time (half bridge circuit) ≤ 30 ns for best efficiency
- Top of FET (back side) is electrically connected to source

Questions: Ask a GaN Expert

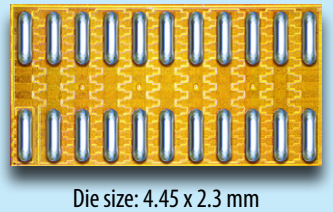
Maximum Ratings			
PARAMETER		**VALUE**	**UNIT**
V_{DS}	Drain-to-Source Voltage (Continuous)	100	V
$V_{DS(tr)}$	Drain-to-Source Voltage (Repetitive Transient)(1)	120	
I_D	Continuous (T_A = 25°C)	64	A
	Pulsed (25°C, T_{PULSE} = 10 µs)	467	
	Pulsed (125°C, T_{PULSE} = 10 µs)	374	
V_{GS}	Gate-to-Source Voltage	6	V
	Gate-to-Source Voltage	-4	
T_J	Operating Temperature	-40 to 150	°C
T_{STG}	Storage Temperature	-40 to 150	

(1) Pulsed repetitively, duty cycle factor (DC_{Factor}) ≤ 1%;
See Figure 13 and Reliability Report Phase 16, Section 3.2.6

Thermal Characteristics			
PARAMETER		**TYP**	**UNIT**
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case (Case TOP)	0.4	°C/W
$R_{\theta JB}$	Thermal Resistance, Junction-to-Board (Case BOTTOM)	1.5	
$R_{\theta JA_JEDEC}$	Thermal Resistance, Junction-to-Ambient (using JEDEC 51-2 PCB)	59	
$R_{\theta JA_EVB}$	Thermal Resistance, Junction-to-Ambient (using EPC90146 EVB)	31	

Static Characteristics (T_J = 25°C unless otherwise stated)						
PARAMETER		**TEST CONDITIONS**	**MIN**	**TYP**	**MAX**	**UNIT**
BV_{DSS}	Drain-to-Source Voltage	V_{GS} = 0 V, I_D = 0.15 mA	100			V
I_{DSS}	Drain-Source Leakage	V_{GS} = 0 V, V_{DS} = 80 V		0.001	0.12	mA
I_{GSS}	Gate-to-Source Forward Leakage	V_{GS} = 5 V		0.03	3.2	
	Gate-to-Source Forward Leakage#	V_{GS} = 5 V, T_J = 125°C		0.3	7.1	
	Gate-to-Source Reverse Leakage	V_{GS} = -4 V		0.006	0.17	
$V_{GS(TH)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 13 mA	0.7	1.3	2.5	V
$R_{DS(on)}$	Drain-Source On Resistance	V_{GS} = 5 V, I_D = 30 A		1.7	2.2	mΩ
V_{SD}	Source-Drain Forward Voltage#	I_S = 0.5 A, V_{GS} = 0 V		1.5		V

Defined by design. Not subject to production test.



Die size: 4.45 x 2.3 mm

EPC2071 eGaN® FETs are supplied only in passivated die form with solder bars.

Applications

- 48 V DC-DC converters
- BLDC motor drives
- Sync rectification for AC/DC and DC-DC
- Point of load converters
- Solar converters
- Lidar
- eMobility

Benefits

- Ultra high efficiency
- No reverse recovery
- Ultra low Q_G, Q_{GD}, Q_{OSS}
- Ultra low $R_{DS(on)}$
- Ultra small footprint

Scan QR code or click link below for more information including reliability reports, device models, demo boards!

https://l.ead.me/EPC2071

Dynamic Characteristics# (T_J = 25°C unless otherwise stated)						
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
C_{ISS}	Input Capacitance	V_{DS} = 50 V, V_{GS} = 0 V		2664	3931	pF
C_{RSS}	Reverse Transfer Capacitance			5.4		
C_{OSS}	Output Capacitance			878	976	
$C_{OSS(ER)}$	Effective Output Capacitance, Energy Related (Note 1)	V_{DS} = 0 to 50 V, V_{GS} = 0 V		1058		
$C_{OSS(TR)}$	Effective Output Capacitance, Time Related (Note 2)			1422		
R_G	Gate Resistance			0.3		Ω
Q_G	Total Gate Charge	V_{DS} = 50 V, V_{GS} = 5 V, I_D = 30 A		18	26	nC
Q_{GS}	Gate-to-Source Charge	V_{DS} = 50 V, I_D = 30 A		6.0		
Q_{GD}	Gate-to-Drain Charge			1.8		
$Q_{G(TH)}$	Gate Charge at Threshold			4.5		
Q_{OSS}	Output Charge	V_{DS} = 50 V, V_{GS} = 0 V		71	82	
Q_{RR}	Source-Drain Recovery Charge (Note 3)			0		

Defined by design. Not subject to production test.
All measurements were done with substrate connected to source.
Note 1: $C_{OSS(ER)}$ is a fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS}.
Note 2: $C_{OSS(TR)}$ is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS}.
Note 3: GaN FET do not have an anti-parallel body diode, and hence do not exhibit reverse recovery. However they can operate in the third quadrant, and their reverse conduction characteristic is shown in Figure 8.

Figure 1: Typical Output Characteristics at 25°C*

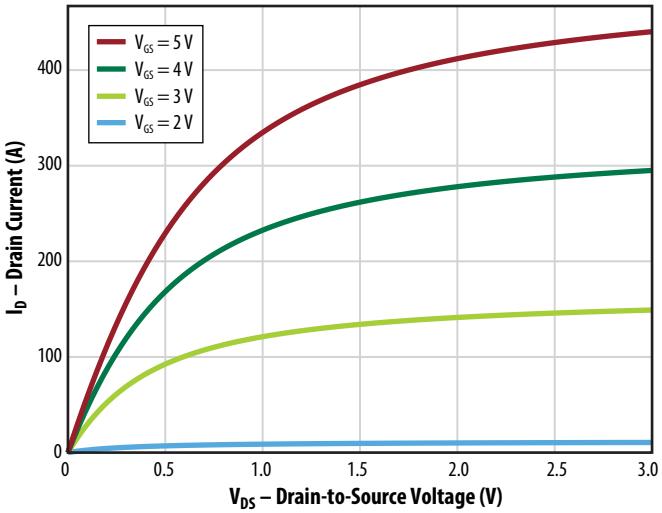


Figure 2: Typical Transfer Characteristics*

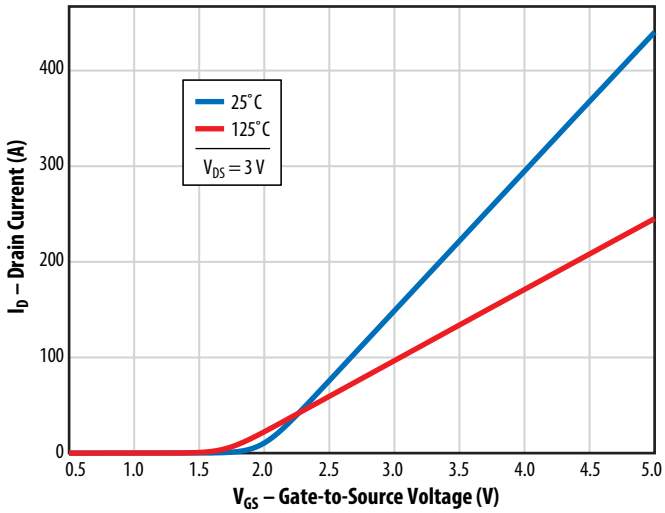


Figure 3: Typical $R_{DS(on)}$ vs. V_{GS} for Various Drain Currents

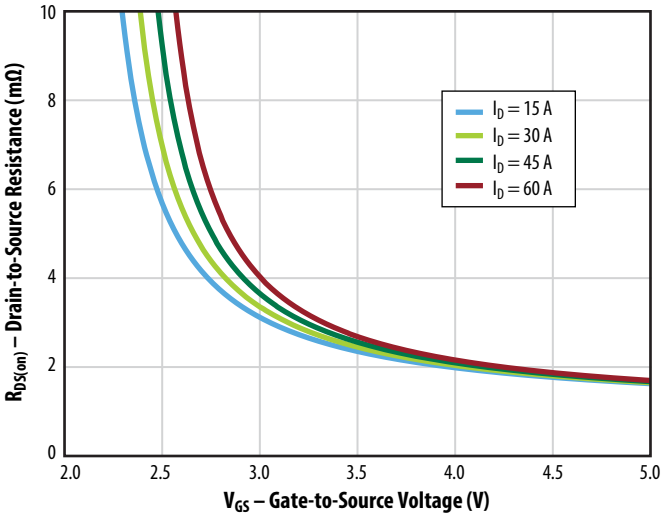
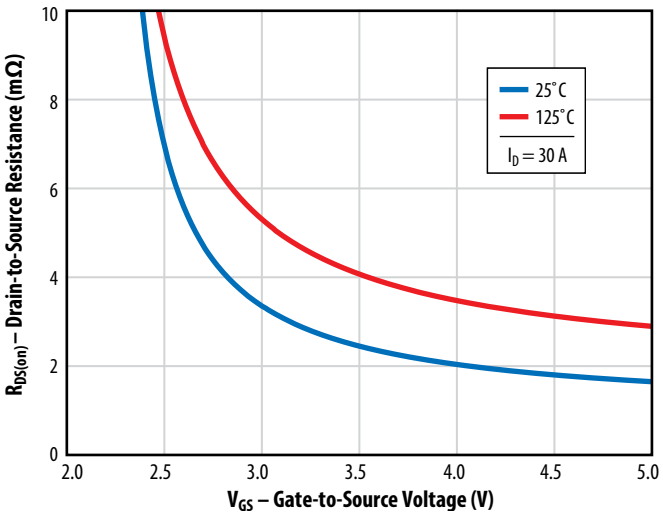


Figure 4: Typical $R_{DS(on)}$ vs. V_{GS} for Various Temperatures



* Generated based on a pulse width of 300 µs.

Figure 5a: Typical Capacitance (Linear Scale)

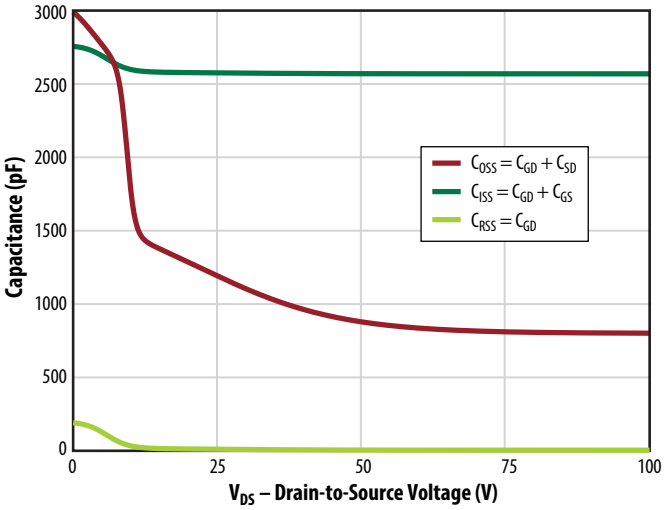


Figure 5b: Typical Capacitance (Log Scale)

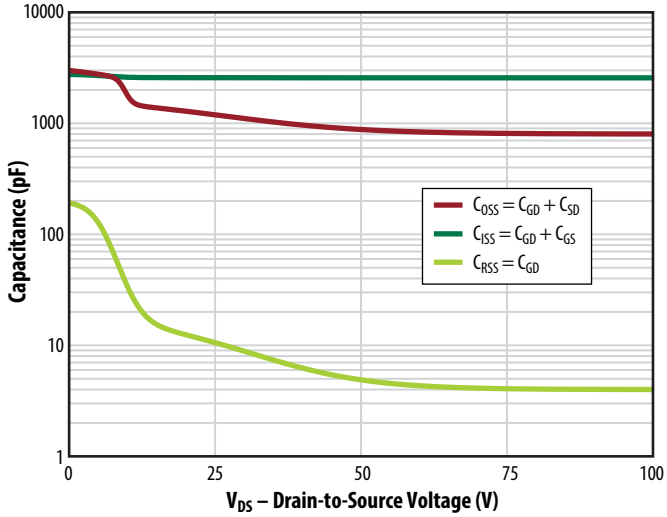


Figure 6: Typical Output Charge and C_{OSS} Stored Energy

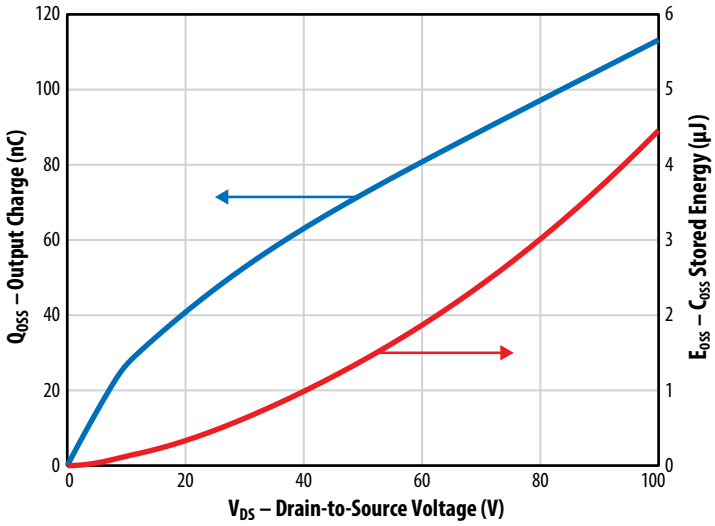


Figure 7: Typical Gate Charge

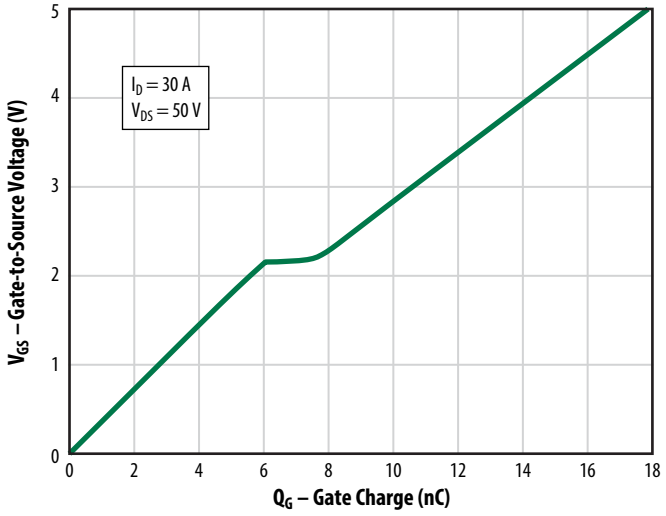


Figure 8: Typical Reverse Drain-Source Characteristics*

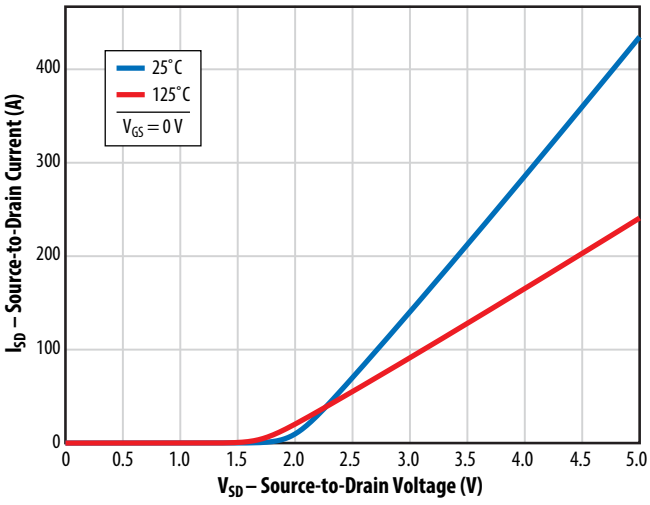
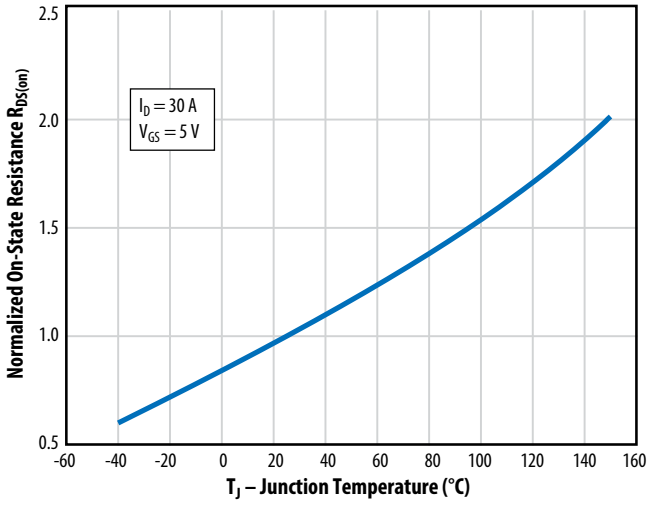


Figure 9: Typical Normalized On-State Resistance vs. Temp.



Note: Negative gate drive voltage increases the reverse drain-source voltage.
EPC recommends 0 V for OFF.
* Generated based on a pulse width of 300 µs.

Figure 10: Typical Normalized Threshold Voltage vs. Temp.

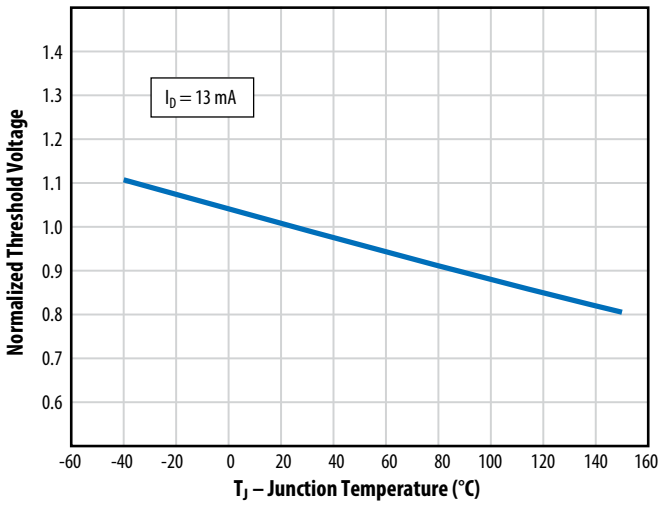
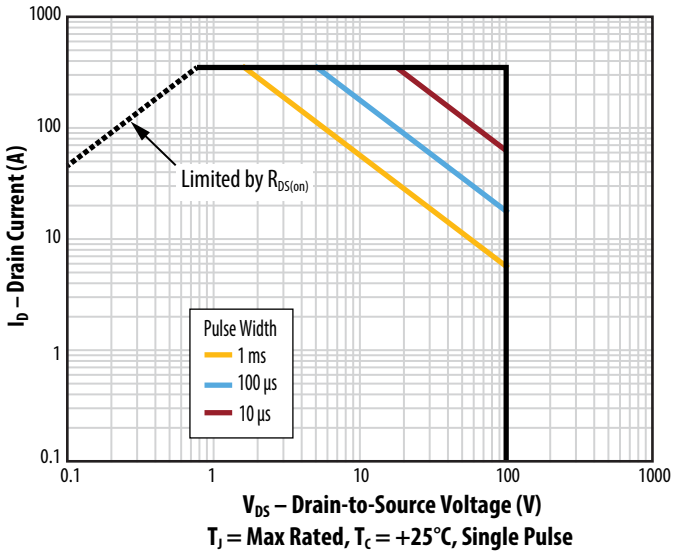
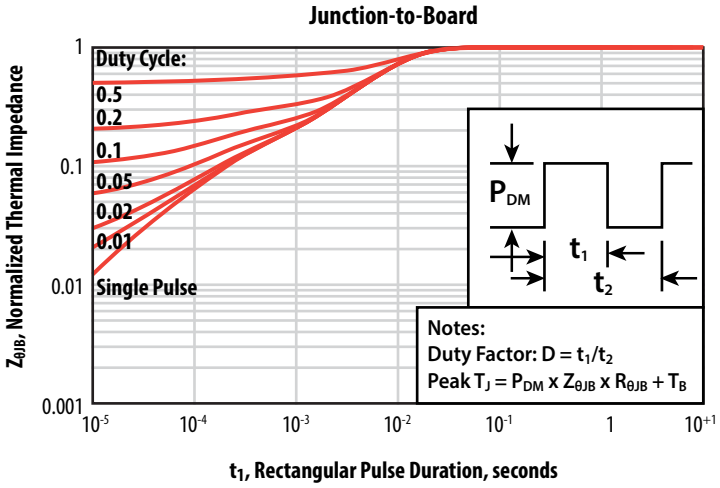


Figure 11: Safe Operating Area



T_J = Max Rated, T_C = +25°C, Single Pulse

Figure 12: Typical Transient Thermal Response Curves



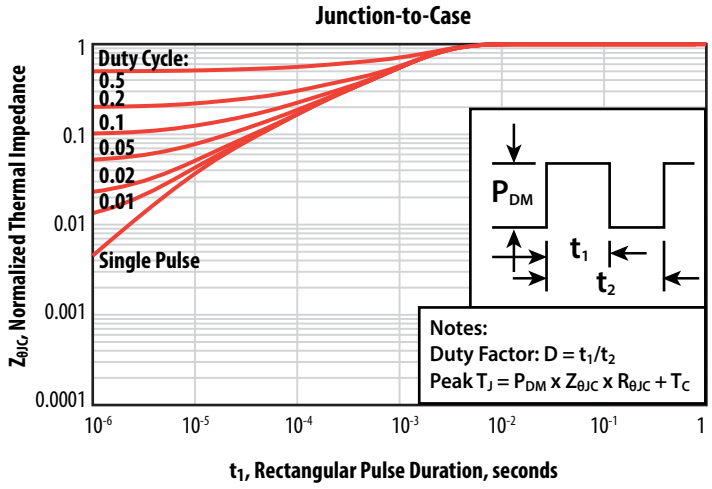
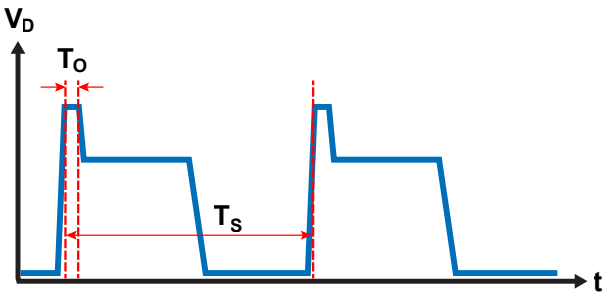


Figure 13: Duty Cycle Factor (DC_{Factor}) Illustration for Repetitive Overvoltage Specification



1% is the ratio between T_O (overvoltage duration) and T_S (one switching period).

LAYOUT CONSIDERATIONS

GaN transistors generally behave like power MOSFETs, but at much higher switching speeds and power densities, therefore layout considerations are very important, and care must be taken to minimize layout parasitic inductances. The recommended design utilizes the first inner layer as a power loop return path. This return path is located directly beneath the top layer's power loop allowing for the smallest physical loop size. This method is also commonly referred to as flux cancellation. Variations of this concept can be implemented by placing the bus capacitors either next to the high side device, or next to the low side device, or between the low and high side devices, but in all cases the loop is closed using the first inner layer right beneath the devices.

A similar concept is also used for the gate loop, with the return gate loop located directly under the turn ON and OFF gate resistors.

Furthermore, to minimize the common source inductance between power and gate loops, the power and gate loops are laid out perpendicular to each other, and a via next to the source pad closest to the gate pad is used as Kelvin connection for the gate driver return path.

The **EPC90146 Quick Start Guide – 100 V, 40 A Half-Bridge Development Board Using EPC2071** implements our recommended vertical inner layout.

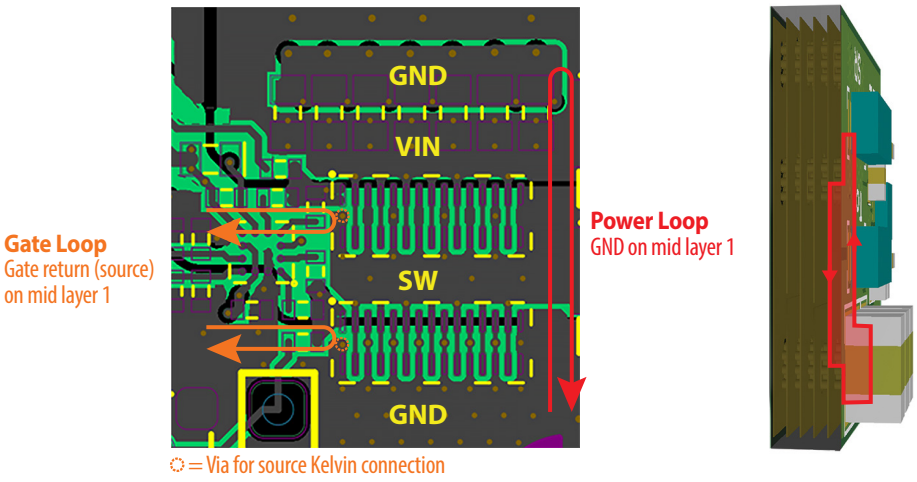


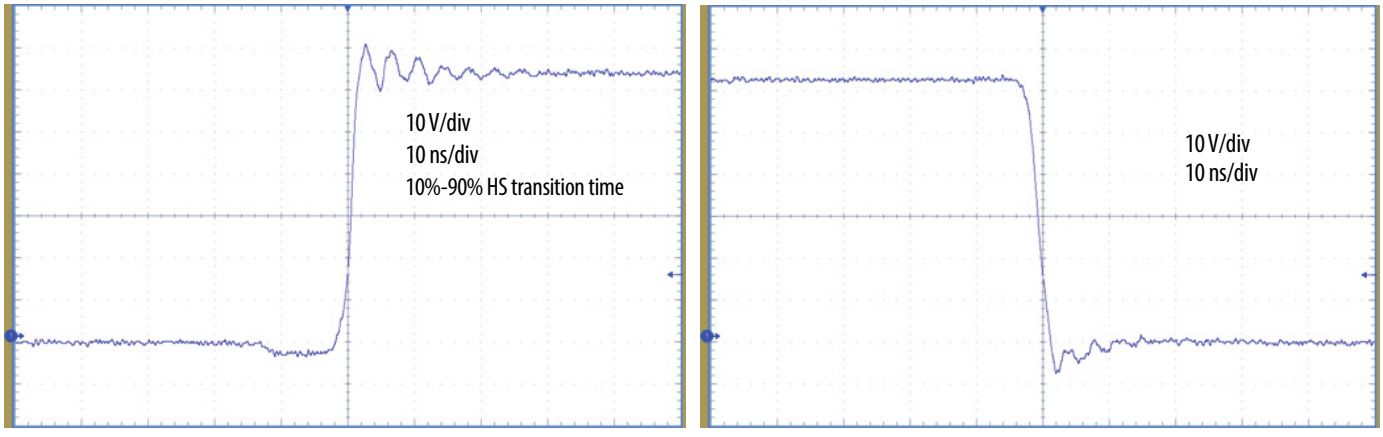
Figure 13: Inner vertical layout for power and gate loops from EPC90146

Detailed recommendations on layout can be found on EPC's website: **Optimizing PCB Layout with eGaN FETs.pdf**

TYPICAL SWITCHING BEHAVIOR

The following typical switching waveforms are captured in these conditions:

- **EPC90146 – 100 V, 40 A Half-bridge Development Board using EPC2071**
- Gate driver: uP1966E with 0.4 Ω/0.7 Ω pull-down/pull-up resistance
- External $R_G(ON)$ = 0 Ω, $R_G(OFF)$ = 0 Ω
- V_{IN} = 64 V, I_L = 32A



Typical turn ON: 29 V/ns

Typical turn OFF: 17 V/ns

Figure 14: Typical half-bridge voltage switching waveforms

See the **EPC90146 Quick Start Guide (QSG)** for more information.

TYPICAL THERMAL CONCEPT

The EPC2071 can take advantage of dual sided cooling to maximize its heat dissipation capabilities in high power density designs. ***Note that the top of EPC FETs are connected to source potential, so for half-bridge topologies the Thermal Interface Material (TIM) needs to provide electrical isolation to the heatsink.***

Recommended best practice thermal solutions are covered in detail in How2AppNote012 - How to Get More Power Out of an eGaN Converter.pdf.

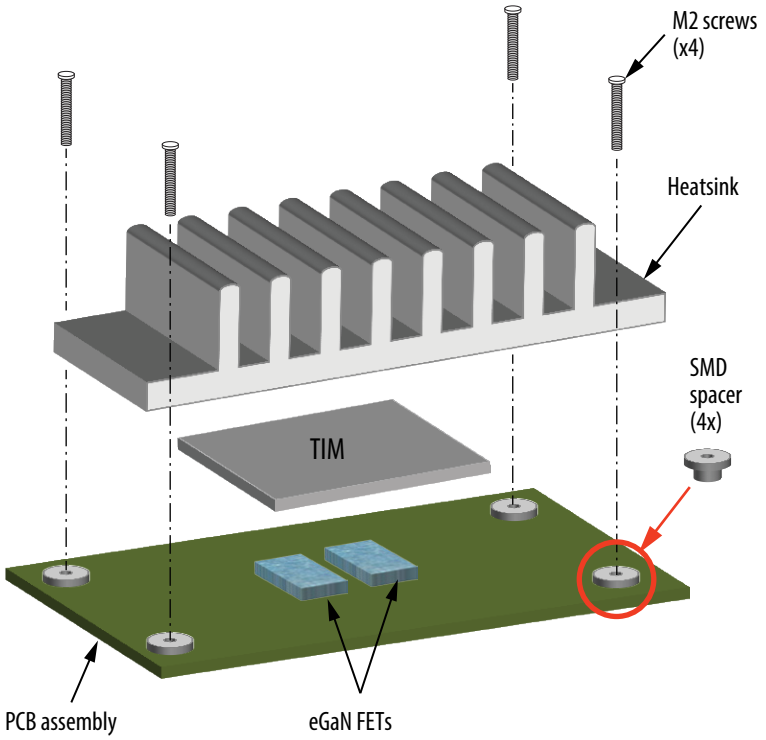


Figure 15: Exploded view of heatsink assembly using screws

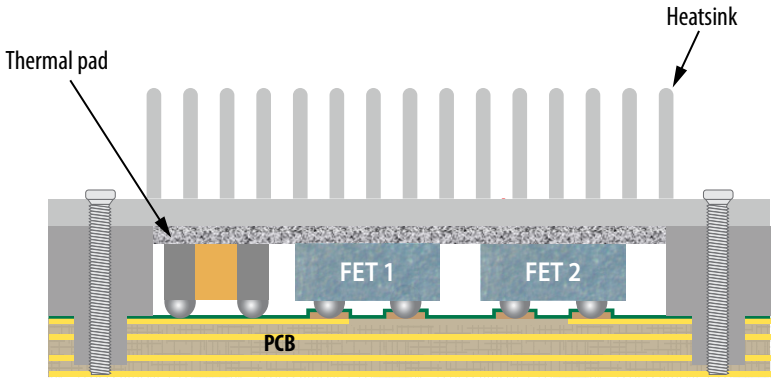


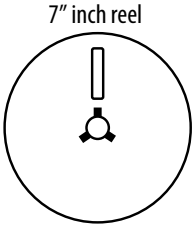
Figure 16: A cross-section image of dual sided thermal solution

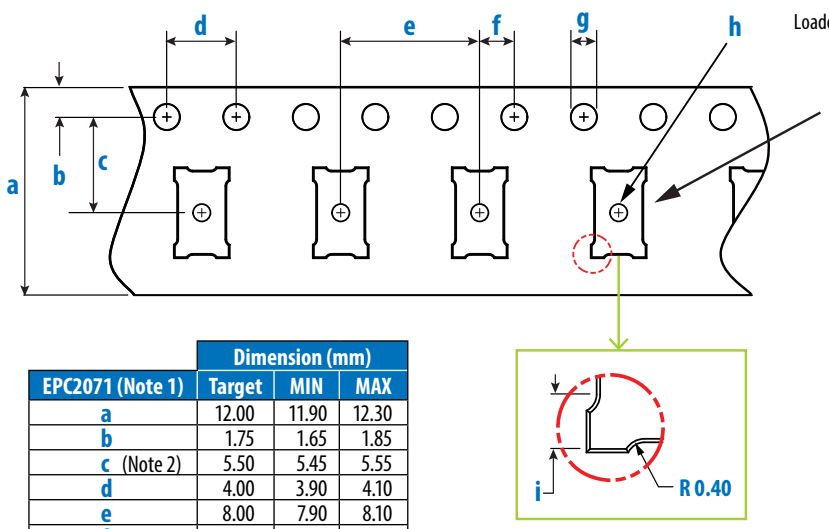
Note: Connecting the heatsink to ground is recommended and can significantly improve radiated EMI

The thermal design can be optimized by using the GaN FET Thermal Calculator on EPC's website.

TAPE AND REEL CONFIGURATION

8 mm pitch, 12 mm wide tape on 7" reel



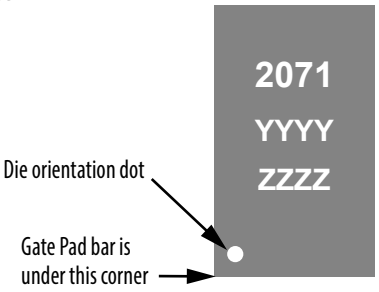


EPC2071 (Note 1)	Dimension (mm) Target	MIN	MAX
a	12.00	11.90	12.30
b	1.75	1.65	1.85
c (Note 2)	5.50	5.45	5.55
d	4.00	3.90	4.10
e	8.00	7.90	8.10
f (Note 2)	2.00	1.95	2.05
g	1.50	1.50	1.60
h	1.00	0.95	1.05
i	1.02		

Note 1: MSL 1 (moisture sensitivity level 1) classified according to IPC/JEDEC industry standard.

Note 2: Pocket position is relative to the sprocket hole measured as true position of the pocket, not the pocket hole.

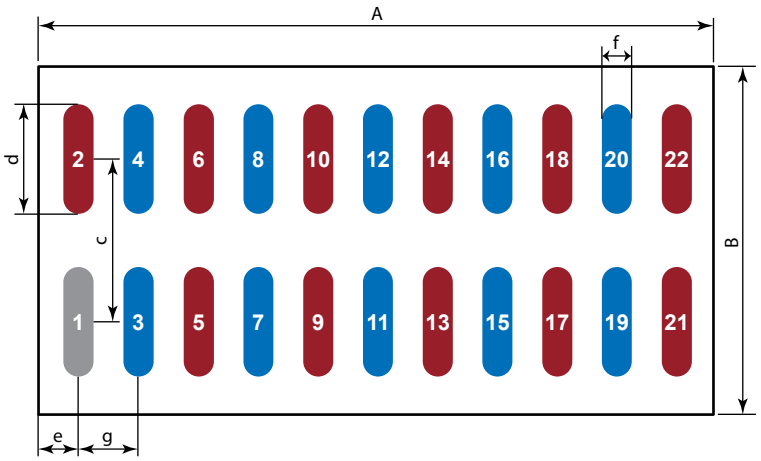
DIE MARKINGS



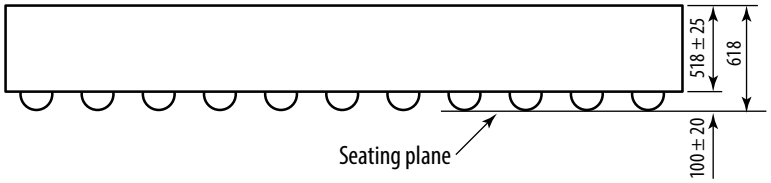
Part Number	Laser Markings Part # Marking Line 1	Lot_Date Code Marking Line 2	Lot_Date Code Marking Line 3
EPC2071	2071	YYYY	ZZZZ

DIE OUTLINE

Solder Bump View



Side View



DIM	Micrometers		
	MIN	Nominal	MAX
A	4420	4450	4480
B	2270	2300	2330
c		1330	
d		720	
e		225	
f		200	
g		400	

Pad 1 is Gate;

Pads 2 ,5, 6, 9, 10, 13, 14, 17, 18, 21, 22 are Source;

Pads 3, 4, 7, 8, 11, 12, 15, 16, 19, 20 are Drain;

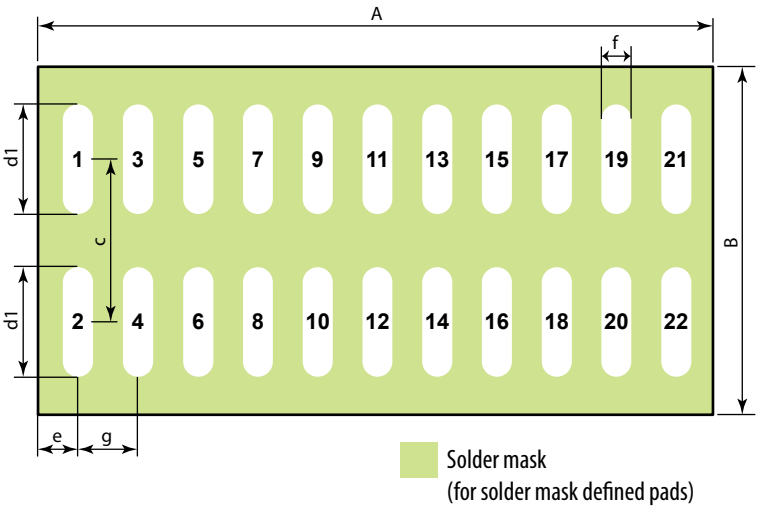
*Substrate (top side) connected to Source

Solder bump material:

Solder Alloy Sn/1.8Ag : **IPC/JEDEC J-STD-609 solder alloy e-code : e2**

RECOMMENDED LAND PATTERN

(units in µm)



DIM	Micrometers
A	4450
B	2300
c	1330
d1	700
e	225
f	180
g	400

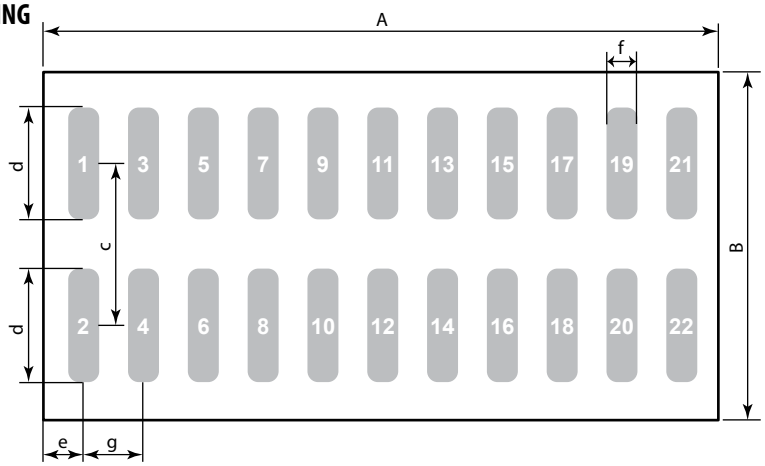
Pad 1 is Gate;

Pads 2, 5, 6, 9,10,13,14, 17, 18, 21, 22 are Source;

Pads 3, 4, 7, 8, 11, 12, 15, 16, 19, 20 are Drain

RECOMMENDED STENCIL DRAWING

(units in µm)



DIM	Micrometers
A	4450
B	2300
c	1330
d	700
e	225
f	180
g	400

Recommended stencil should be 4 mil (100 µm) thick, must be laser cut, openings per drawing.

The corner has a radius of R60 µm.

Intended for use with SAC305 Type 4 solder, reference 88.5% metals content.

ADDITIONAL RESOURCES AVAILABLE

Solder mask defined pads are recommended for best reliability.

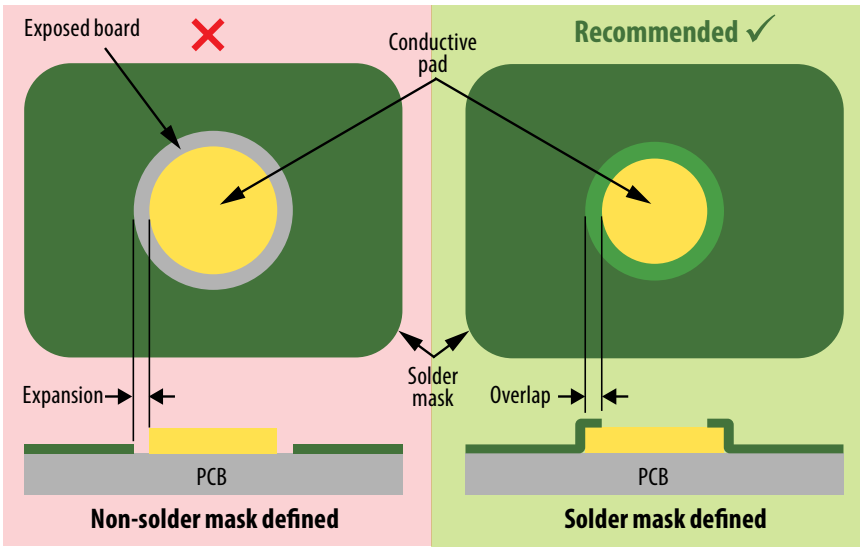


Figure 17: Solder mask defined versus non-solder mask defined pad

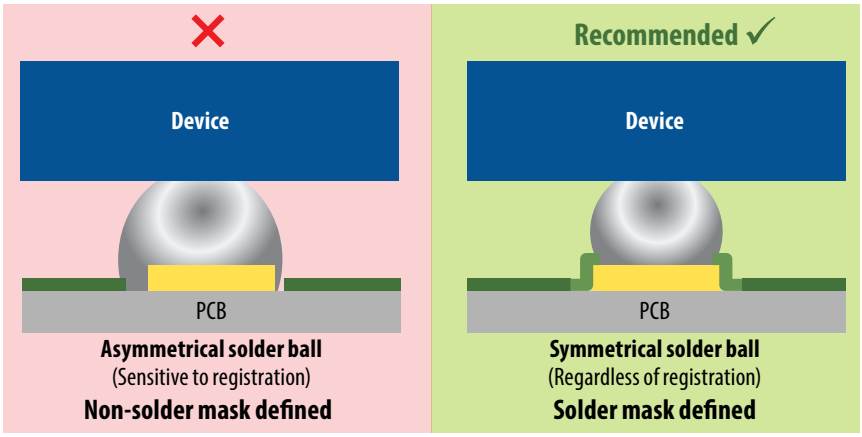


Figure 18: Effect of solder mask design on the solder ball symmetry

- Assembly resources – https://epc-co.com/epc/Portals/0/epc/documents/product-training/Appnote_GaNassembly.pdf
- Library of Altium footprints for production FETs and ICs – https://epc-co.com/epc/documents/altium-files/EPC%20Altium%20Library.zip (for preliminary device Altium footprints, contact EPC)

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Parça koduyla arama

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Entegreden kapasitöre tüm elektronik komponent kategorileri.

Kategorilere göz atın

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Aradığınız üreticinin ürünlerini tek sayfada inceleyin.

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